

**Search Notes**

Application/Control No.

10/617,172

Examiner

Tianjie Chen

Applicant(s)/Patent under  
Reexamination

KIM ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
360	98.08		
	99.05		
	99.12	9/27/2006	TJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Report	9/27/2006	TJ